Subst. Form PTO-1449	Atty. Docket No.: RPS920010172US1 (IRA-10-5709)	Serial No.: To be assigned
APPLICANT'S INFORMATION DISCLOSURE STATEMENT		
	Applicant: Atoji et al	
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U.S. PATENT DOCUMENTS

Initial*		Document No.	Date	Name	Class	Subcl.	Filing Date
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MPF	AT	"Verification by Behavorial Modeling – A Multiprocessor System Case, Conference on ASIC Proceedings", October 21-24, 1996, pgs 43-45
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Examiner: Mark P. Francis	Date Considered: 7/6/06

*EXAMINER: Initial if reference considered, whether or not citation is in conformation with MPEP 609; draw line through citation if in conformance and not considered. Include copy of this form with next communication to applicant.

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